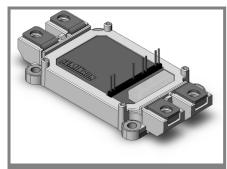
# SEMIX 452GB176HD



SEMiX<sup>TM</sup> 2

### Trench IGBT Modules

#### SEMiX 452GB176HD

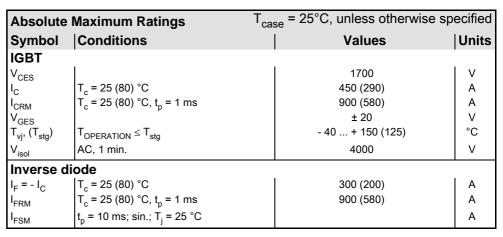
**Target Data** 

#### **Features**

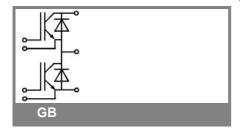
- Homogeneous Si
- Trench = Trenchgate technology
- V<sub>CE(sat)</sub> with positive temperature coefficient
- · High short circuit capability

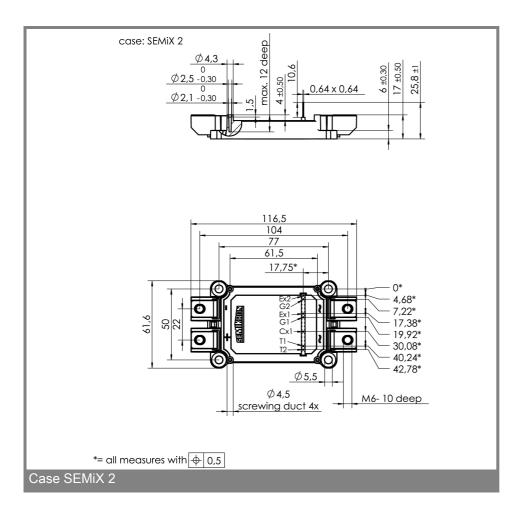
## **Typical Applications**

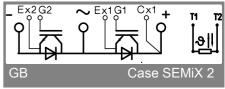
- AC inverter drives
- UPS
- Electronic welders



Characteristics T <sub>case</sub> = 25°C, unless otherwise spec					pecified
Symbol	Conditions	min.	typ.	max.	Units
IGBT		•			
$V_{GE(th)}$ $I_{CES}$ $V_{CE(TO)}$	$V_{GE} = V_{CE}, I_{C} = 12 \text{ mA}$ $V_{GE} = 0, V_{CE} = V_{CES}, T_{j} = 25 (125) ^{\circ}C$ $T_{i} = 25 (125) ^{\circ}C$	5,2	5,8 1 (0,9)	6,4 2,4 1,2 (1,1)	V mA V
r <sub>CE</sub>	V <sub>GF</sub> = 15 V, T <sub>i</sub> = 25 (125) °C		3,3 (5,2)	4,2 (6)	mΩ
V <sub>CE(sat)</sub>	I <sub>C</sub> = 300 A, V <sub>GE</sub> = 15 V, T <sub>j</sub> = 25 (125) °C, chip level		2 (2,45)		V
C <sub>ies</sub> C <sub>oes</sub> C <sub>res</sub> L <sub>CE</sub>	under following conditions $V_{GE} = 0, V_{CE} = 25 \text{ V}, f = 1 \text{ MHz}$		20 1,1 0,9 18		nF nF nF nH
R <sub>CC'+EE'</sub>	resistance, terminal-chip, T <sub>c</sub> = 25 (125) °C				mΩ
$t_{d(on)}/t_r$ $t_{d(off)}/t_f$	V <sub>CC</sub> = 1200 V, I <sub>C</sub> = 300 A V <sub>GE</sub> = ± 15 V				ns ns
$E_{on} \left( E_{off} \right)$	$R_{Gon} = R_{Goff} = \Omega$ , $T_j = 125  ^{\circ}C$		200 (100)		mJ
Inverse d	iode				
$V_F = V_{EC}$	$I_F$ = 300 A; $V_{GE}$ = 0 V; $T_j$ = 25 (125) °C, chip level		2 (2,1)	2,2 (2,3)	V
$egin{aligned} V_{(TO)} \ r_{T} \ l_{RRM} \ Q_{rr} \end{aligned}$	$T_j = 25 (125) ^{\circ}C$ $T_j = 25 (125) ^{\circ}C$ $I_F = 300 \text{ A; } T_j = 25 (125) ^{\circ}C$ $di/dt = A/\mu s$		1,1 (0,9) 3 (4)	1,3 (1,1) 3 (4)	V mΩ A μC
E <sub>rr</sub>	V <sub>GE</sub> = 0 V				mJ
$\begin{aligned} &\textbf{Thermal c}\\ &\textbf{R}_{\text{th(j-c)}}\\ &\textbf{R}_{\text{th(j-c)D}}\\ &\textbf{R}_{\text{th(j-c)FD}}\\ &\textbf{R}_{\text{th(c-s)}}\end{aligned}$	characteristics per IGBT per Inverse Diode per FWD per module		0,045	0,07 0,17	K/W K/W K/W
Temperat	ure sensor				
R <sub>25</sub> B <sub>25/85</sub>	$T_c = 25  ^{\circ}\text{C}$ $R_2 = R_1 = \exp[B(1/T_2 - 1/T_1)] \; ; \; T[K]; B$		5 ±5% 3420		kΩ K
Mechanical data					
$M_s/M_t$	to heatsink (M5) / for terminals (M6)	3/2,5	236	5 /5	Nm g







This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

This technical information specifies semiconductor devices but promises no characteristics. No warranty or guarantee expressed or implied is made regarding delivery, performance or suitability.

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